

Notice of References Cited

Application/Control No.

10/566,993

Applicant(s)/Patent Under
Reexamination
AREDDU ET AL.

Examiner

FAN NG

Art Unit

4145

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,356,584	04-2008	Yip, John	709/224
*	C	US-6,873,600	03-2005	Duffield et al.	370/252
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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